

- **Members of the Texas Instruments Widebus™ Family**
- **State-of-the-Art EPIC-IIIB™ BiCMOS Design Significantly Reduces Power Dissipation**
- **Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17**
- **Typical  $V_{OLP}$  (Output Ground Bounce) < 1 V at  $V_{CC} = 5$  V,  $T_A = 25^\circ\text{C}$**
- **Distributed  $V_{CC}$  and GND Pin Configuration Minimizes High-Speed Switching Noise**
- **Flow-Through Architecture Optimizes PCB Layout**
- **High-Drive Outputs ( $-32$ -mA  $I_{OH}$ ,  $64$ -mA  $I_{OL}$ )**
- **Package Options Include Plastic 300-mil Shrink Small-Outline (DL) and Thin Shrink Small-Outline (DGG) Packages and 380-mil Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Spacings**

### description

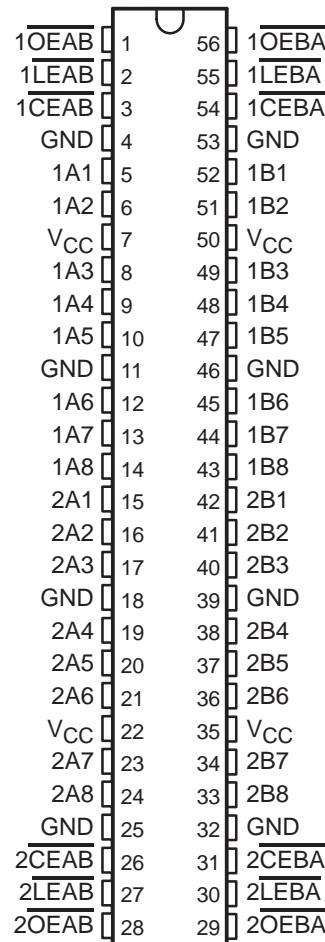
The 'ABT16543 16-bit registered transceivers contain two sets of D-type latches for temporary storage of data flowing in either direction. The 'ABT16543 can be used as two 8-bit transceivers or one 16-bit transceiver. Separate latch-enable ( $\overline{LEAB}$  or  $\overline{LEBA}$ ) and output-enable ( $\overline{OEAB}$  or  $\overline{OEBA}$ ) inputs are provided for each register to permit independent control in either direction of data flow.

The A-to-B enable ( $\overline{CEAB}$ ) input must be low to enter data from A or to output data from B. If  $\overline{CEAB}$  is low and  $\overline{LEAB}$  is low, the A-to-B latches are transparent; a subsequent low-to-high transition of  $\overline{LEAB}$  puts the A latches in the storage mode. With  $\overline{CEAB}$  and  $\overline{OEAB}$  both low, the 3-state B outputs are active and reflect the data present at the output of the A latches. Data flow from B to A is similar but requires using the  $\overline{CEBA}$ ,  $\overline{LEBA}$ , and  $\overline{OEBA}$  inputs.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT16543 is characterized for operation over the full military temperature range of  $-55^\circ\text{C}$  to  $125^\circ\text{C}$ . The SN74ABT16543 is characterized for operation from  $-40^\circ\text{C}$  to  $85^\circ\text{C}$ .

SN54ABT16543 . . . WD PACKAGE  
SN74ABT16543 . . . DGG OR DL PACKAGE  
(TOP VIEW)



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**SN54ABT16543, SN74ABT16543  
16-BIT REGISTERED TRANSCEIVERS  
WITH 3-STATE OUTPUTS**

SCBS087C – FEBRUARY 1991 – REVISED JANUARY 1997

**FUNCTION TABLE<sup>†</sup>**  
(each 8-bit section)

INPUTS				OUTPUT B
CEAB	<u>LEAB</u>	<u>OEAB</u>	A	
H	X	X	X	Z
X	X	H	X	Z
L	H	L	X	$B_0^{\ddagger}$
L	L	L	L	L
L	L	L	H	H

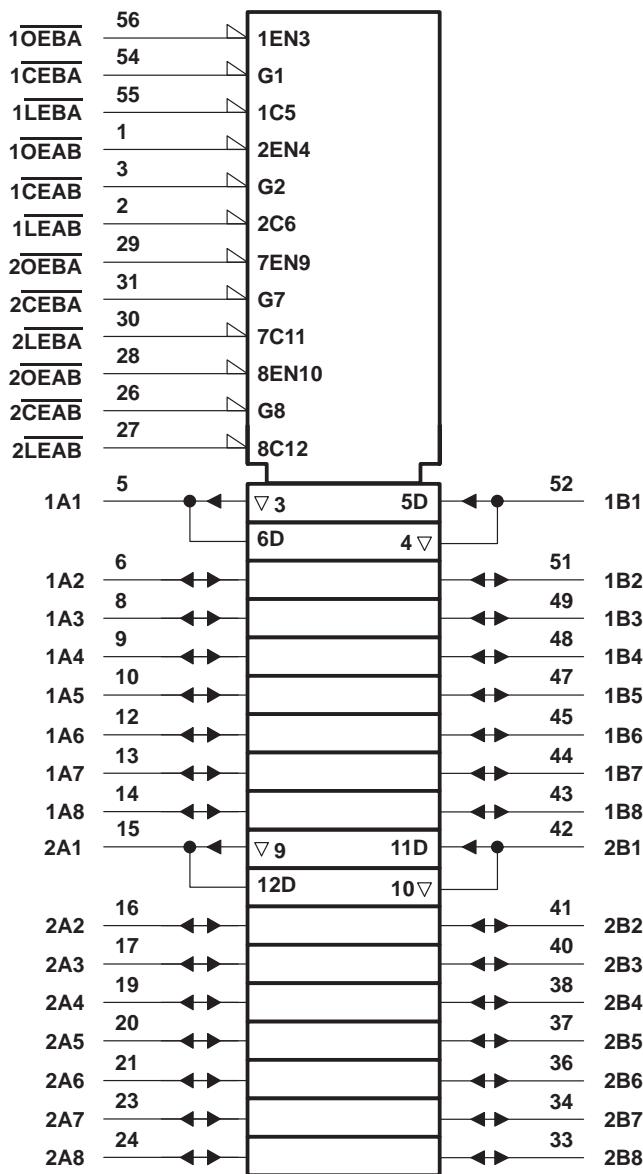
<sup>†</sup> A-to-B data flow is shown; B-to-A flow control is the same except that it uses CEBA, LEBA, and OEBA.

<sup>‡</sup> Output level before the indicated steady-state input conditions were established



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logic symbol†

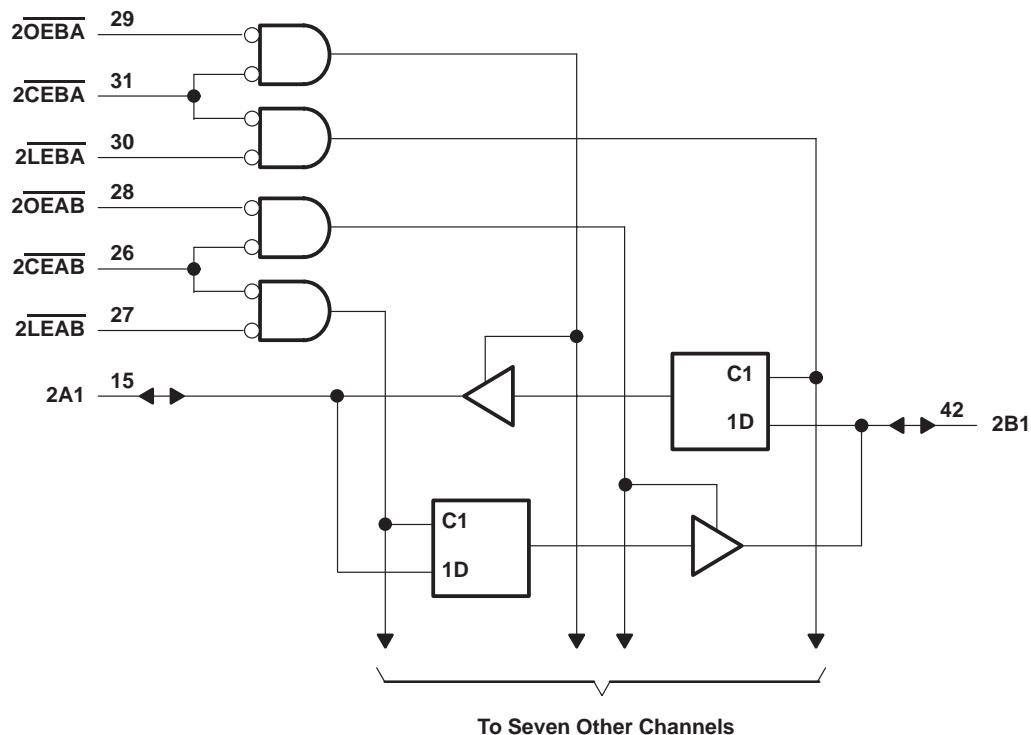
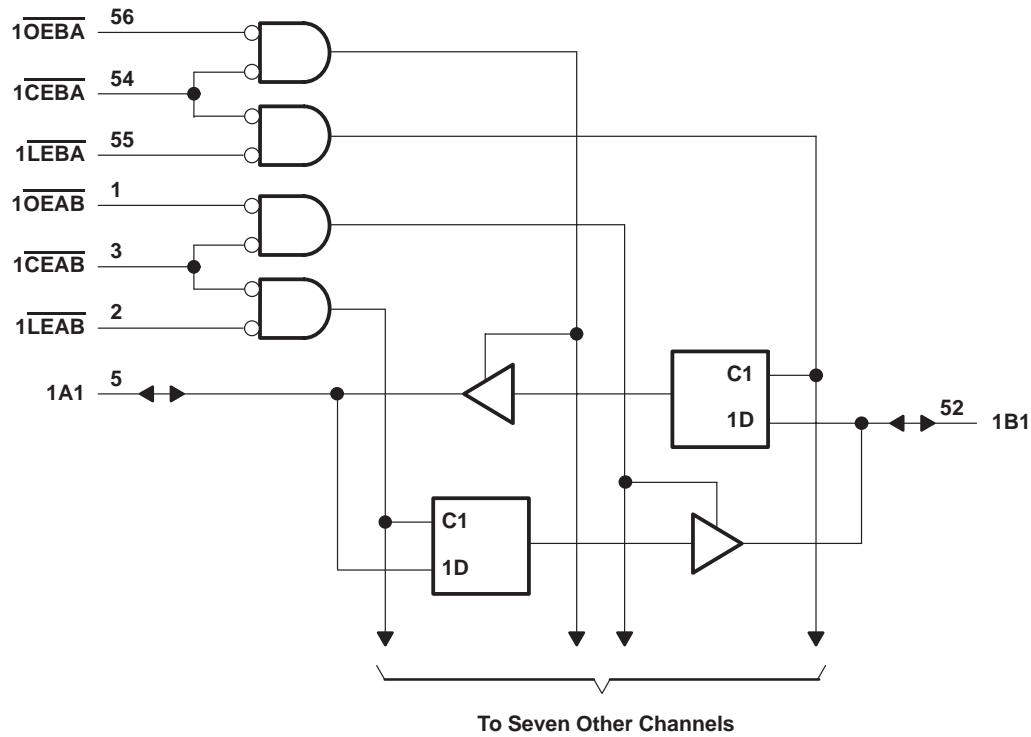


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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**logic diagram (positive logic)**



**absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†**

Supply voltage range, $V_{CC}$ .....	.....	–0.5 V to 7 V
Input voltage range, $V_I$ (except I/O ports) (see Note 1) .....	.....	–0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, $V_O$ .....	.....	–0.5 V to 5.5 V
Current into any output in the low state, $I_O$ : SN54ABT16543 .....	.....	96 mA
SN74ABT16543 .....	.....	128 mA
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	.....	–18 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ ) .....	.....	–50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2): DGG package .....	.....	81°C/W
DL package .....	.....	74°C/W
Storage temperature range, $T_{stg}$ .....	.....	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.  
 2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

**recommended operating conditions (see Note 3)**

		SN54ABT16543		SN74ABT16543		UNIT
		MIN	MAX	MIN	MAX	
$V_{CC}$	Supply voltage	4.5	5.5	4.5	5.5	V
$V_{IH}$	High-level input voltage	2	.....	2	.....	V
$V_{IL}$	Low-level input voltage	.....	0.8	.....	0.8	V
$V_I$	Input voltage	0	$V_{CC}$	0	$V_{CC}$	V
$I_{OH}$	High-level output current	.....	–24	.....	–32	mA
$I_{OL}$	Low-level output current	.....	48	.....	64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	.....	Outputs enabled	10	10	ns/V
$T_A$	Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: Unused pins (input or I/O) must be held high or low to prevent them from floating.

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**electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)**

PARAMETER	TEST CONDITIONS	$T_A = 25^\circ\text{C}$			SN54ABT16543		SN74ABT16543		UNIT
		MIN	TYP†	MAX	MIN	MAX	MIN	MAX	
$V_{IK}$	$V_{CC} = 4.5\text{ V}$ , $I_I = -18\text{ mA}$			-1.2		-1.2		-1.2	V
$V_{OH}$	$V_{CC} = 4.5\text{ V}$ , $I_{OH} = -3\text{ mA}$	2.5		2.5		2.5			V
	$V_{CC} = 5\text{ V}$ , $I_{OH} = -3\text{ mA}$	3		3		3			
	$V_{CC} = 4.5\text{ V}$ , $I_{OH} = -24\text{ mA}$	2		2					
	$I_{OH} = -32\text{ mA}$	2*					2		
$V_{OL}$	$V_{CC} = 4.5\text{ V}$	$I_{OL} = 48\text{ mA}$		0.55		0.55			V
		$I_{OL} = 64\text{ mA}$		0.55*				0.55	
$V_{hys}$		100							mV
$I_I$	Control inputs	$V_{CC} = 5.5\text{ V}$ , $V_I = V_{CC}$ or GND			±1		±1	±1	$\mu\text{A}$
	A or B ports				±100		±100	±100	
$I_{OZH}^\ddagger$	$V_{CC} = 5.5\text{ V}$ , $V_O = 2.7\text{ V}$			50**		10		50	$\mu\text{A}$
$I_{OZL}^\ddagger$	$V_{CC} = 5.5\text{ V}$ , $V_O = 0.5\text{ V}$			-50**		-10		-50	$\mu\text{A}$
$I_{off}$	$V_{CC} = 0$ , $V_I$ or $V_O \leq 4.5\text{ V}$			±100				±100	$\mu\text{A}$
$I_{CEX}$	$V_{CC} = 5.5\text{ V}$ , $V_O = 5.5\text{ V}$	Outputs high		50		50		50	$\mu\text{A}$
$I_O^\S$	$V_{CC} = 5.5\text{ V}$ , $V_O = 2.5\text{ V}$	-50	-100	-200	-50	-200	-50	-200	mA
$I_{CC}$	A or B ports	$V_{CC} = 5.5\text{ V}$ , $I_O = 0$ , $V_I = V_{CC}$ or GND	Outputs high		2		2	2	mA
		Outputs low		35		35		35	
		Outputs disabled		2		2		2	
$\Delta I_{CC}^\ $	$V_{CC} = 5.5\text{ V}$ , One input at 3.4 V, Other inputs at $V_{CC}$ or GND			0.5		0.5		0.5	mA
$C_i$	Control inputs	$V_I = 2.5\text{ V}$ or $0.5\text{ V}$		3					pF
$C_{io}$	A or B ports	$V_O = 2.5\text{ V}$ or $0.5\text{ V}$		8.5					pF

\* On products compliant to MIL-PRF-38535, this parameter does not apply.

\*\* These limits apply only to the SN74ABT16543.

† All typical values are at  $V_{CC} = 5\text{ V}$ .

‡ The parameters  $I_{OZH}$  and  $I_{OZL}$  include the input leakage current.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

¶ This is the increase in supply current for each input that is at the specified TTL voltage level rather than  $V_{CC}$  or GND.

**timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)**

			$V_{CC} = 5\text{ V}$ , $T_A = 25^\circ\text{C}$		SN54ABT16543		SN74ABT16543		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
$t_W$	Pulse duration, LEAB or LEBA low			4		4		4	ns
$t_{SU}$	Setup time, data before LEAB↑ or LEBA↑			High	1.5	1.5	1.5		ns
				Low	3.5	3.5	3.5		
$t_h$	Hold time, data after LEAB↑ or LEBA↑			High	1.5	1.5	1.5		ns
				Low	2	2	2		

SN54ABT16543, SN74ABT16543  
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switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50 \text{ pF}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54ABT16543			UNIT	
			$V_{CC} = 5 \text{ V}$ , $T_A = 25^\circ\text{C}$		MIN	UNIT	
			MIN	TYP	MAX		
$t_{PLH}$	A or B	B or A	0.8	2.5	3.3	0.8	3.9
$t_{PHL}$			0.9	2.7	4.4	0.9	5.2
$t_{PLH}$	$\overline{LE}$	A or B	1	3.1	4.3	1	5.3
$t_{PHL}$			1.2	3.3	4.8	1.2	5.7
$t_{PZH}$	$\overline{OE}$	A or B	0.8	3.4	4.3	0.8	5.3
$t_{PZL}$			1.1	3.8	7	1.1	7.9
$t_{PHZ}$	$\overline{OE}$	A or B	1.9	4	6.3	1.9	7.2
$t_{PLZ}$			1.6	3.3	4.6	1.6	5
$t_{PZH}$	$\overline{CE}$	A or B	0.9	3.8	4.9	0.9	6.3
$t_{PZL}$			1.2	4.2	6.8	1.2	7.9
$t_{PHZ}$	$\overline{CE}$	A or B	2	4.5	6.4	2	7.3
$t_{PLZ}$			1.7	3.9	5.1	1.7	5.6

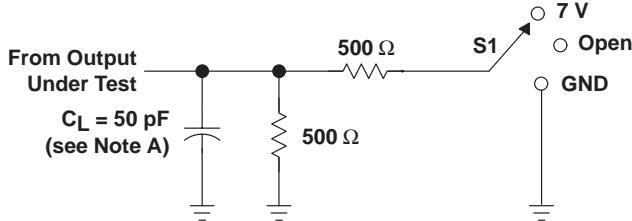
switching characteristics over recommended ranges of supply voltage and operating free-air temperature,  $C_L = 50 \text{ pF}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN74ABT16543			UNIT	
			$V_{CC} = 5 \text{ V}$ , $T_A = 25^\circ\text{C}$		MIN	UNIT	
			MIN	TYP	MAX		
$t_{PLH}$	A or B	B or A	1	2.5	3.3	1	3.8
$t_{PHL}$			1	2.7	4.4	1	5.1
$t_{PLH}$	$\overline{LE}$	A or B	1	3.1	4.3	1	5.2
$t_{PHL}$			1.2	3.3	4.8	1.2	5.6
$t_{PZH}$	$\overline{OE}$	A or B	1	3.4	4.3	1	5.2
$t_{PZL}$			1.1	3.8	5.9	1.1	7
$t_{PHZ}$	$\overline{OE}$	A or B	1.9	4	5	1.9	5.7
$t_{PLZ}$			1.6	3.3	4.2	1.6	4.6
$t_{PZH}$	$\overline{CE}$	A or B	1	3.8	4.9	1	6.2
$t_{PZL}$			1.2	4.2	6.5	1.2	7.8
$t_{PHZ}$	$\overline{CE}$	A or B	2	4.5	5.6	2	6.6
$t_{PLZ}$			1.7	3.9	5.1	1.7	5.4

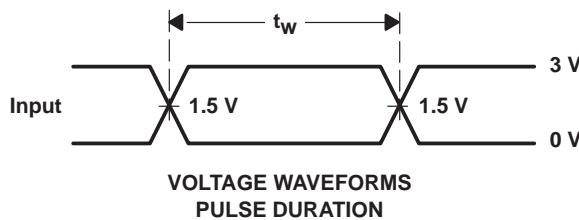
# SN54ABT16543, SN74ABT16543 16-BIT REGISTERED TRANSCEIVERS WITH 3-STATE OUTPUTS

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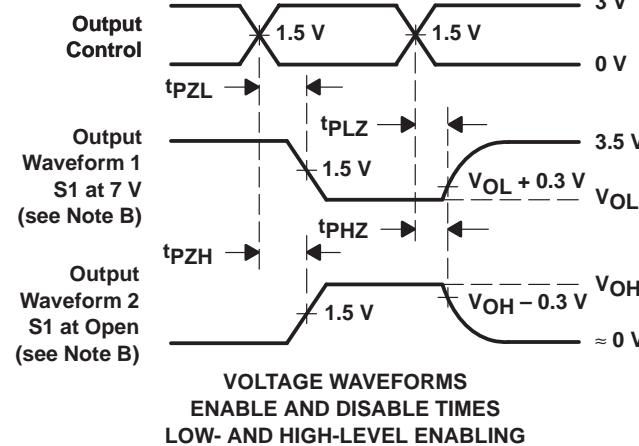
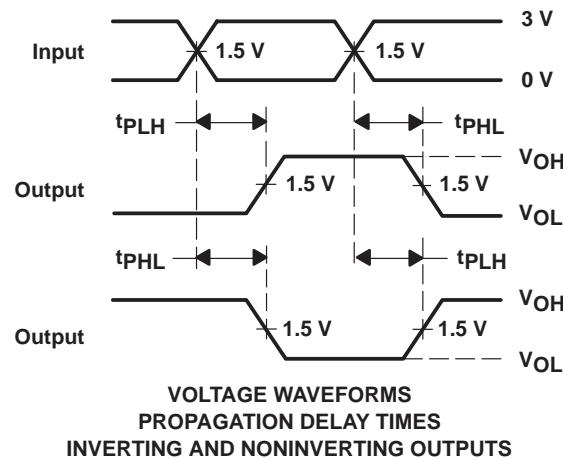
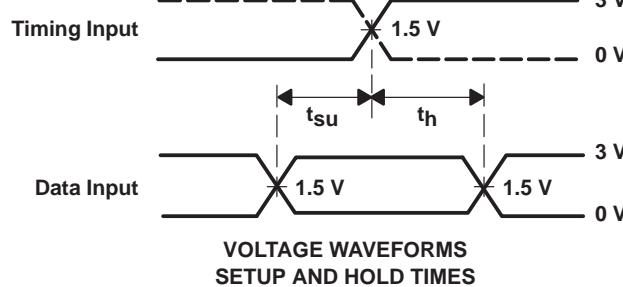
## PARAMETER MEASUREMENT INFORMATION



LOAD CIRCUIT



TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	7 V
$t_{PHZ}/t_{PZH}$	Open



- NOTES: A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq 10 \text{ MHz}$ ,  $Z_O = 50 \Omega$ ,  $t_r \leq 2.5 \text{ ns}$ ,  $t_f \leq 2.5 \text{ ns}$ .
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

**PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
5962-9324101Mxa	ACTIVE	CFP	WD	56	1	TBD	Call TI	Level-NC-NC-NC
74ABT16543DGGRE4	ACTIVE	TSSOP	DGG	56	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74ABT16543DGGR	ACTIVE	TSSOP	DGG	56	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74ABT16543DL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT16543DLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT16543DLR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT16543DLRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SNJ54ABT16543WD	ACTIVE	CFP	WD	56	1	TBD	Call TI	Level-NC-NC-NC

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

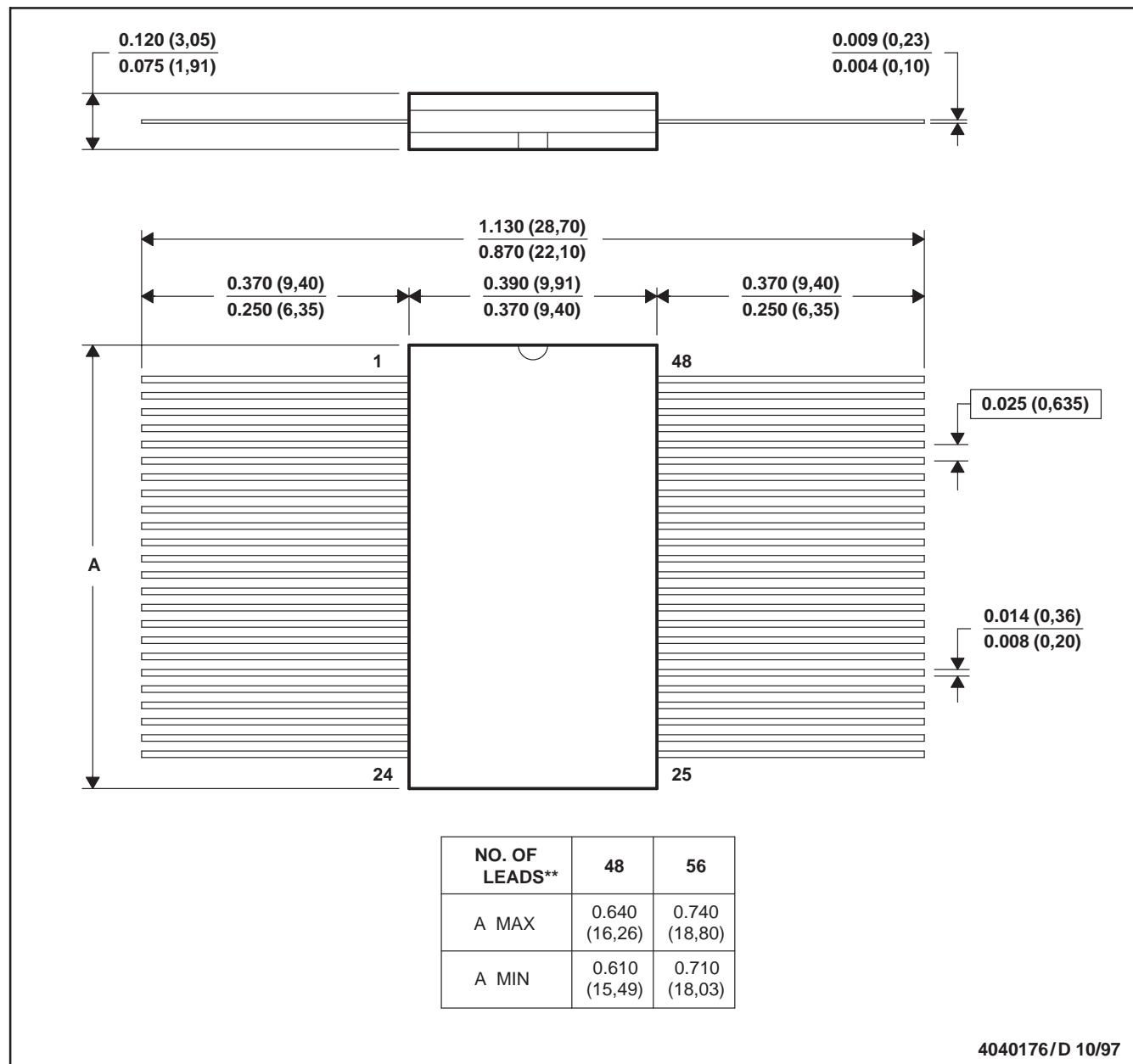
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WD (R-GDFP-F\*\*)

CERAMIC DUAL FLATPACK

48 LEADS SHOWN

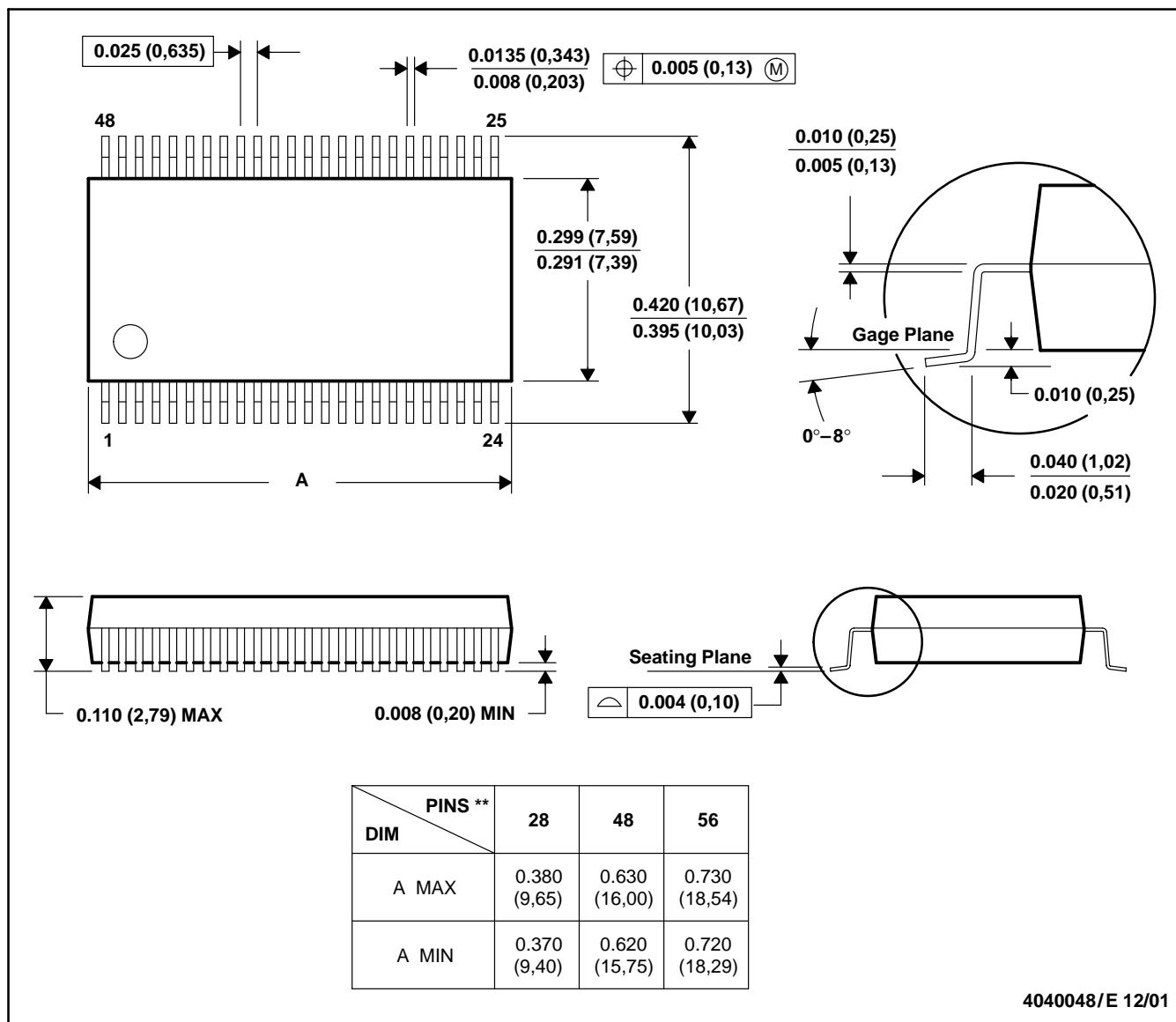


- NOTES: A. All linear dimensions are in inches (millimeters).  
 B. This drawing is subject to change without notice.  
 C. This package can be hermetically sealed with a ceramic lid using glass frit.  
 D. Index point is provided on cap for terminal identification only.  
 E. Falls within MIL STD 1835: GDFP1-F48 and JEDEC MO-146AA  
 GDFP1-F56 and JEDEC MO-146AB

## DL (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN

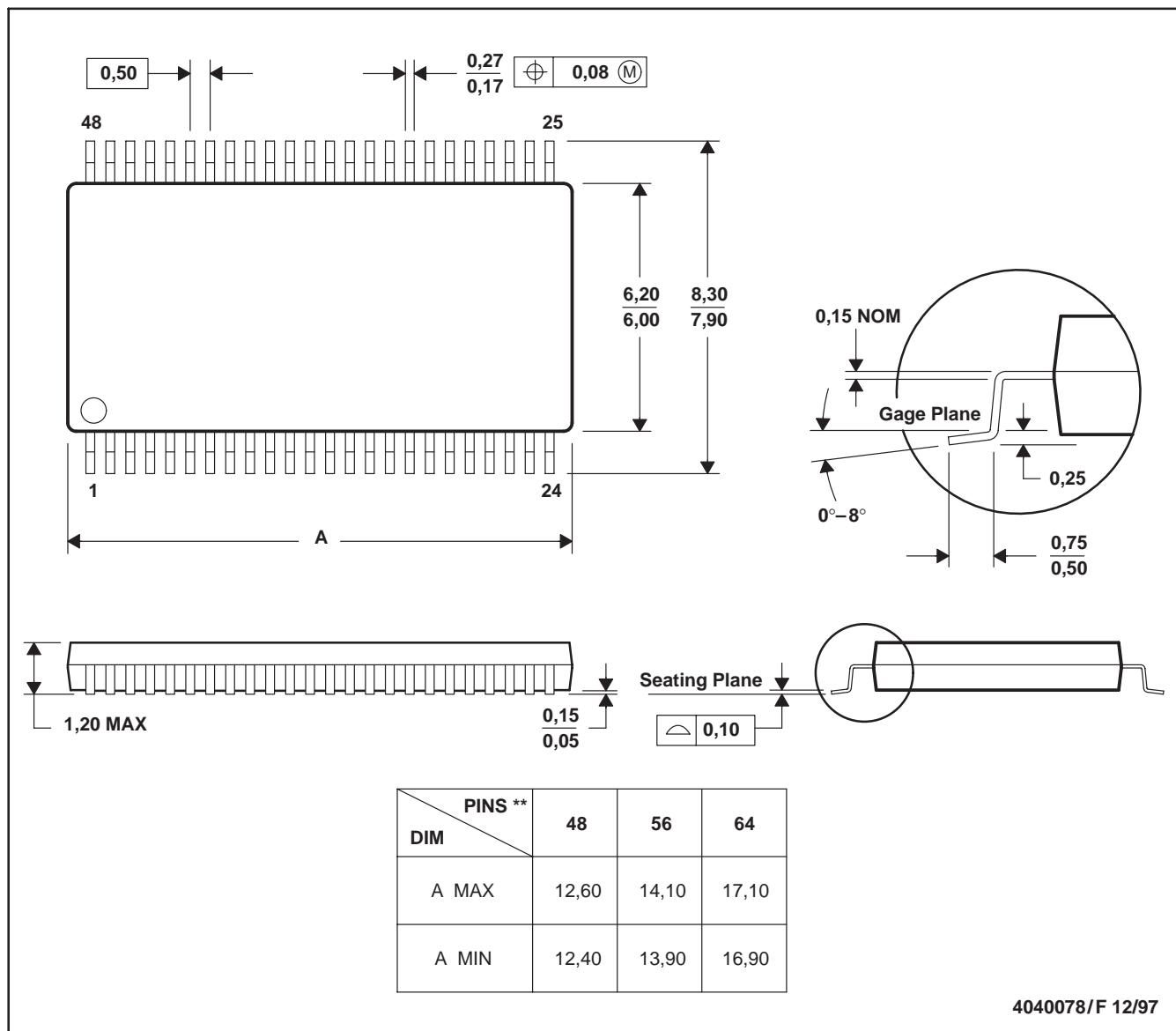


- NOTES: A. All linear dimensions are in inches (millimeters).  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).  
 D. Falls within JEDEC MO-118

DGG (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold protrusion not to exceed 0,15.  
 D. Falls within JEDEC MO-153

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